

Sheet, 1 of 1		INFORMATION DISCLOSURE STATEMENT							
FORM PTO 1449 (modified)  U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE  LIST OF REFERENCES CITED BY APPLICANT(S) <i>(Use several sheets if necessary)</i>  Date Submitted to PTO: September 12, 2005				ATTY DOCKET NO. 2005-0541A		SERIAL NO. 10/529,881			
				APPLICANT Hiroaki MISAWA et al.					
				FILING DATE April 1, 2005			GROUP		
U.S. PATENT DOCUMENTS									
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE		
	AA								
	AB								
	AC								
	AD								
	AE								
FOREIGN PATENT DOCUMENTS									
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO		
G	AF	11-71139	3/1999	JP			X		
	AG								
	AH								
	AI								
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)									
G	AJ	Toshiaki KONDO et al., "Femtosecond laser interference technique with diffractive beam splitter for fabrication of three-dimensional photonic crystals", Applied Physics Letters, August 6, 2001, Vol. 79, No. 6, pgs. 725-727.							
G	AK	MATSUO, "Technique for Producing Photonic Crystals", Optical and Electro-optical Engineering contact, August 2002, Vol. 40, No. 8, pgs. 480-489 with English translation.							
G	AL	Toshiaki KONDO et al., "Multiphoton fabrication of periodic structures by multibeam interference of femtosecond pulses", Applied Physics Letters, April 28, 2003, Vol. 82, No. 17, pgs. 2758-2760.							
G	AM	Shigeki MATSUO et al., "Fabrication of Three-Dimensional Photonic Crystals by Femtosecond Laser Interference", Proceedings of SPIE, Vol. 4655, 2002, pgs. 327-334.							
G	AN	Saulius JUODKAZIS, "Optical Properties of Femtosecond Irradiated Photo-Thermo-Refractive Glass", Lithuanian Journal of Physics, vol. 42, No. 2, 119-126 (2002), pgs. 1-8.							
G	AO	S. JUODKAZIS et al., "Three-dimensional recording by femtosecond pulses in dielectrics", Proceedings of SPIE Reprint, Vol. 4977, January 27-30, 2003, pgs. 94-107.							
EXAMINER				DATE CONSIDERED <i>October 25/2006</i>					

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of form with next communication to applicant.